Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/672,151	JACOBS ET AL.
Examiner	Art Unit
Binh X. Tran	1765

SEARCHED						
Class	Subclass	Date	Examiner			
438	712	12/21/2005	вт			
438	723	12/21/2005	ВТ			
438	724	12/21/2005	вт			
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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(INCLUDING	RCH NOT SEARCH S	ES STRATEGY)
		DATE	EXMR
Update search		12/21/2005	ВТ
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